

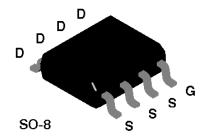
NDS8410 Single N-Channel Enhancement Mode Field Effect Transistor

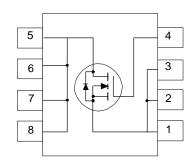
General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance and provide superior switching performance. These devices are particularly suited for low voltage applications such as notebook computer power management and other battery powered circuits where fast switching, low in-line power loss, and resistance to transients are needed.

Features

- High density cell design for extremely low R_{DS(ON)}.
- High power and current handling capability in a widely used surface mount package.





Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		NDS8410	Units
V _{DSS}	Drain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage		20	V
I _D	Drain Current - Continuous	(Note 1a)	± 10	A
	- Pulsed		±50	
P_{D}	Maximum Power Dissipation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1	
T_J , T_{STG}	Operating and Storage Temperature Range		-55 to 150	℃
THERMA	L CHARACTERISTICS	•		•
R _{øJA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
R _{ØJC}	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W

Symbol	Parameter	Conditions	Min	Тур	Max	Units
OFF CHA	RACTERISTICS					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	30			V
oss	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μΑ
		Т	_= 55°C		10	μA
SSF	Gate - Body Leakage, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
SSR	Gate - Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
N CHAR	ACTERISTICS (Note 2)	•		•	•	
GS(th)	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	1	1.5		V
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		0.013	0.015	Ω
		$V_{GS} = 4.5 \text{ V}, I_{D} = 9 \text{ A}$		0.018	0.02	
(on)	On-State Drain Current	V _{GS} = 10 V, V _{DS} = 5 V	20			Α
s	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		22		S
YNAMIC	CHARACTERISTICS		·			
iss	Input Capacitance	$V_{DS} = 15 \text{ V}, \ V_{GS} = 0 \text{ V},$		1350		pF
oss	Output Capacitance	f = 1.0 MHz		800		pF
rss	Reverse Transfer Capacitance			300		pF
WITCHI	NG CHARACTERISTICS (Note 2)					
(on)	Turn - On Delay Time	$V_{DD} = 10 \text{ V}, I_{D} = 1 \text{ A},$		14	30	ns
	Turn - On Rise Time	$V_{GEN} = 10 \text{ V}, R_{GEN} = 6 \Omega$		20	25	ns
(off)	Turn - Off Delay Time			56	100	ns
	Turn - Off Fall Time			31	80	ns
g	Total Gate Charge	$V_{DS} = 15 \text{ V},$		46	60	nC
gs	Gate-Source Charge	$I_D = 10 \text{ A}, \ V_{GS} = 10 \text{ V}$		5.6		nC
) _{gd}	Gate-Drain Charge			14		nC

ELECTRICAL CHARACTERISTICS (T _A = 25°C unless otherwise noted)									
Symbol	Parameter Conditions Min Typ Max U								
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS									
Is	Maximum Continuous Drain-Source Diode Forward Current 2.1								
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 10 \text{ A} \text{ (Note 2)}$		0.8	1.2	V			
t _m	Reverse Recovery Time	$V_{GS} = 0V$, $I_F = 2.1$ A, $dI_F/dt = 100$ A/ μ s			80	ns			

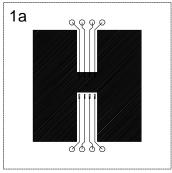
Notes

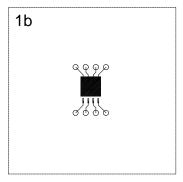
1. $R_{g,lA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{g,lC}$ is guaranteed by design while R_{gCA} is determined by the user's board design.

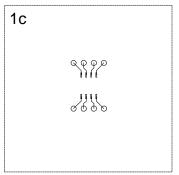
$$P_{D}(t) = \frac{T_{J^{-}}T_{A}}{R_{\theta J}A(t)} = \frac{T_{J^{-}}T_{A}}{R_{\theta J}c^{+}R_{\theta C}A(t)} = I_{D}^{2}(t) \times R_{DS (ON)} \cdot \mathbf{P}_{TJ}$$

Typical R_{BJA} using the board layouts shown below on 4.5"x5" FR-4 PCB in a still air environment:

- a. 50°C/W when mounted on a 1 in² pad of 2oz copper.
- b. 105°C/W when mounted on a 0.04 in² pad of 2oz copper.
- c. 125°C/W when mounted on a 0.006 in² pad of 2oz copper.







Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%.

Typical Electrical Characteristics

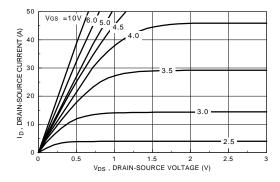


Figure 1. On-Region Characteristics.

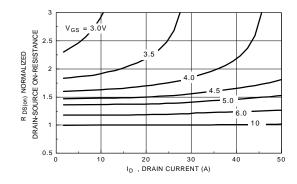


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

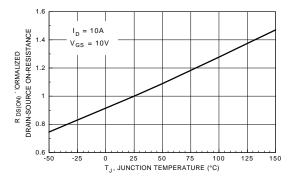


Figure 3. On-Resistance Variation with Temperature.

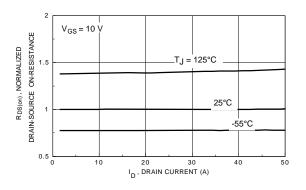


Figure 4. On-Resistance Variation with Drain Current and Temperature.

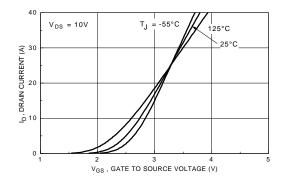


Figure 5. Transfer Characteristics.

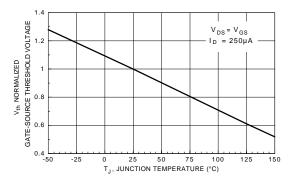


Figure 6. Gate Threshold Variation with Temperature.

Typical Electrical Characteristics (continued)

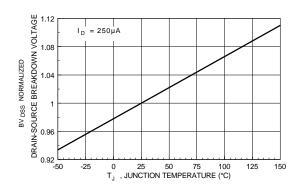


Figure 7. Breakdown Voltage Variation with Temperature.

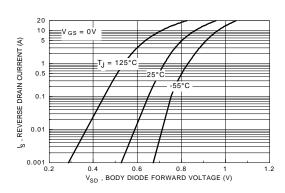


Figure 8. Body Diode Forward Voltage Variation with Source Current and Temperature.

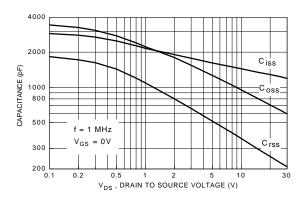


Figure 9. Capacitance Characteristics.

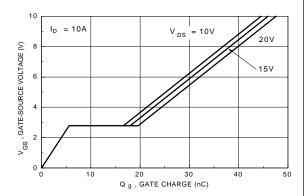


Figure 10. Gate Charge Characteristics.

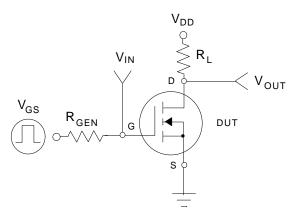


Figure 11. Switching Test Circuit.

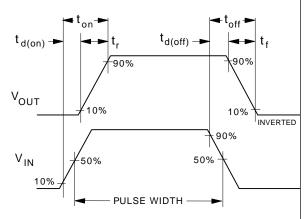


Figure 12. Switching Waveforms.

Typical Electrical and Thermal Characteristics (continued)

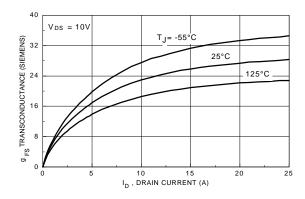
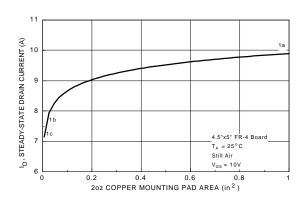


Figure 13. Transconductance Variation with Drain Current and Temperature.

Figure 14. SO-8 Maximum Steady-State Power
Dissipation versus Copper Mounting Pad Area.



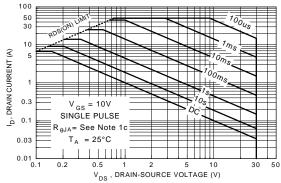


Figure 15. Maximum Steady- State Drain
Current versus Copper Mounting Pad
Area.

Figure 16. Maximum Safe Operating Area.

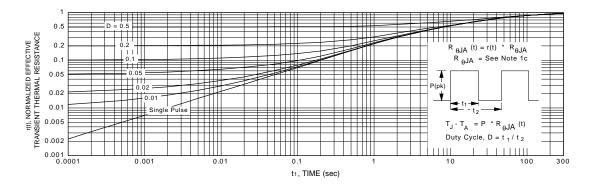
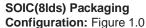


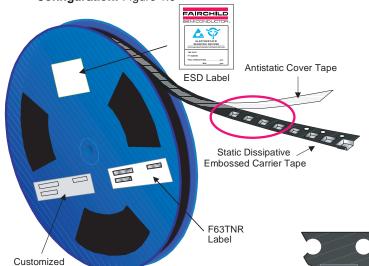
Figure 17. Transient Thermal Response Curve.

Note: Thermal characterization performed using the conditions described in note 1c. Transient thermal response will change depending on the circuit board design.

SO-8 Tape and Reel Data and Package Dimensions







Packaging Description:

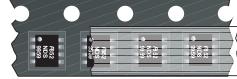
Packaging Description:

SOIC-8 parts are shipped in tape. The carrier tape is made from a dissipative (carbon filled) polycarbonate resin. The cover tape is a multilayer film (Heat Activated Adhesive in nature) primarily composed of polyester film, adhesive layer, sealant, and amit-static sprayed agent. These reeled parts in standard option are shipped with 2,500 units per 13° or 300cm diameter reel. The reels are dark blue in color and is made of polystyrene plastic (anti-static coated). Other option comes in 500 units per 7° or 177cm diameter reel. This and some other options are further described in the Packaging Information table.

These full reles are individually barcode labeled and placed inside a standard intermediate box (illustrated in figure 1.0) made of recyclable corrugated brown paper. One box contains two reels maximum. And these boxes are placed inside a barcode labeled shipping box which comes in different sizes depending on the number of parts shipped.

ESD Label

F63TN Label

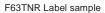




SOIC-8 Unit Orientation

343mm x 342mm x 64mm Standard Intermediate box

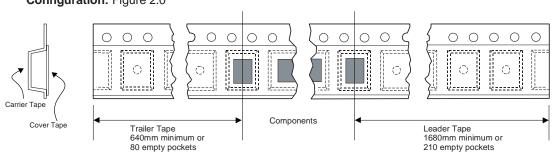
SOIC (8lds) Packaging Information Packaging Option Standard o flow code) L86Z D84Z Rail/Tube TNR Packaging type TNR TNR Qty per Reel/Tube/Bag 2.500 4.000 500 Reel Size 13" Dia 13" Dia 7" Dia Box Dimension (mm) 343y64y343 530x130x83 343y64y343 184v187v47 Max qty per Box 5,000 30,000 8,000 1,000 Weight per unit (gm) 0.0774 0.0774 0.0774 0.0774 Weight per Reel (kg) 0.6060 0.9696 0.1182 Note/Comments



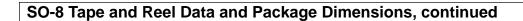
Label



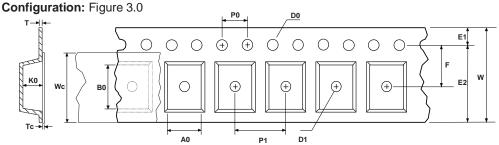
SOIC(8Ids) Tape Leader and Trailer Configuration: Figure 2.0



F63TNL



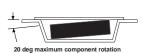
SOIC(8lds) Embossed Carrier Tape





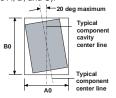
	Dimensions are in millimeter													
Pkg type	A0	В0	w	D0	D1	E1	E2	F	P1	P0	K0	т	Wc	Тс
SOIC(8lds) (12mm)	6.50 +/-0.10	5.30 +/-0.10	12.0 +/-0.3	1.55 +/-0.05	1.60 +/-0.10	1.75 +/-0.10	10.25 min	5.50 +/-0.05	8.0 +/-0.1	4.0 +/-0.1	2.1 +/-0.10	0.450 +/- 0.150	9.2 +/-0.3	0.06 +/-0.02

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



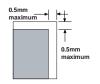
Sketch A (Side or Front Sectional View)
Component Rotation

13" Diameter Option



Sketch B (Top View)

Component Rotation



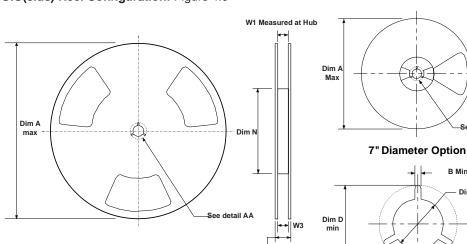
Sketch C (Top View)

Component lateral movement

Dim C

DETAIL AA

SOIC(8lds) Reel Configuration: Figure 4.0

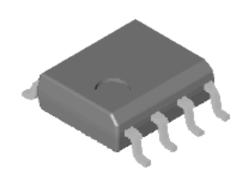


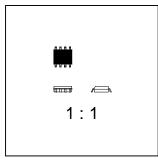
Dimensions are in inches and millimeters									
Tape Size	Reel Option	Dim A	Dim B	Dim C	Dim D	Dim N	Dim W1	Dim W2	Dim W3 (LSL-USL)
12mm	7" Dia	7.00 177.8	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	2.165 55	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4
12mm	13" Dia	13.00 330	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	7.00 178	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4

W2 max Measured at Hub

SO-8 Tape and Reel Data and Package Dimensions, continued

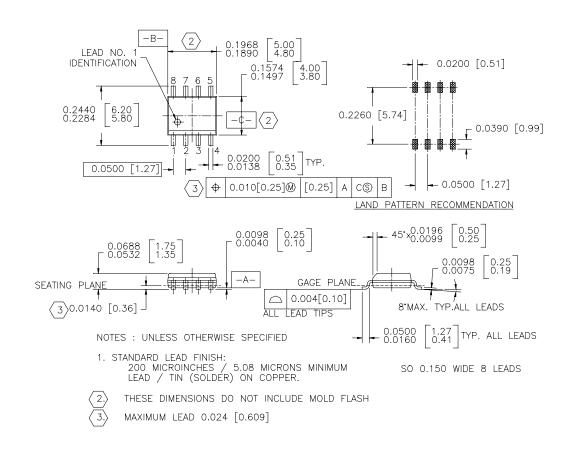
SOIC-8 (FS PKG Code S1)





Scale 1:1 on letter size paper
Dimensions shown below are in:
inches [millimeters]

Part Weight per unit (gram): 0.0774



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FACT™ QFET™ FACT Quiet Series™ QS™

 $\begin{array}{lll} \mathsf{FAST}^{\circledast} & \mathsf{Quiet}\,\mathsf{Series^{\mathsf{TM}}} \\ \mathsf{FASTr^{\mathsf{TM}}} & \mathsf{SuperSOT^{\mathsf{TM}}\text{-}3} \\ \mathsf{GTO^{\mathsf{TM}}} & \mathsf{SuperSOT^{\mathsf{TM}}\text{-}6} \\ \mathsf{HiSeC^{\mathsf{TM}}} & \mathsf{SuperSOT^{\mathsf{TM}}\text{-}8} \\ \end{array}$

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Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
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Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.